

# CS 446/ECE 449: Machine Learning

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## Lecture 9: PAC Learning Theory (I)

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# Recap: Supervised Learning Algorithms

Models we have learned so far:

Model	Linear?	Parametric?	Loss	Generative/ Discriminative
K-nearest neighbor	N	N	N/A	Discriminative
Naive Bayes	Y	Y	NLL	Generative
Logistic regression	Y	Y	Logistic/NLL	Discriminative
Linear SVM	Y	Y	Hinge	Discriminative
Kernelized SVM	N	N	Hinge	Discriminative
Decision Tree	N	N	N/A	Discriminative
AdaBoost	N	N	Exp	Discriminative

**Note:**

- NLL = negative log-likelihood
- Generative = modeling  $\Pr(X, Y)$
- Discriminative = modeling  $\Pr(Y | X)$

# Lecture Today

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- Bayes Error, Bayes Predictor
- Error Decomposition

# Bayes Error Rate

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So far we have learned many different classification algorithms. Beyond their different design choices, how should we compare their performance **theoretically**?

- For a given prediction problem, what is the optimal error that we can hope to achieve? Which predictor will achieve the optimal error?
- Given a problem and a model, how far is our model from the optimal predictor?

# Bayes Error Rate

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The learning process:

- We can choose a predictor  $f$  from some pre-defined class of functions  $\mathcal{F}$ , e.g., the class of linear predictors, decision trees, kernel machines, neural networks, etc.

We also have our training data  $\mathcal{D} := \{(x^{(i)}, y^{(i)})\}_{i=1}^n \sim \mu$  sampled independently and identically (iid) from the underlying distribution  $\mu$  over  $\mathcal{X} \times \mathcal{Y}$

We can then talk about two error measures (classification):

$$\text{Training error: } \hat{\varepsilon}_{\mathcal{D}}(f) := \frac{1}{n} \sum_{i=1}^n \mathbb{I}(f(x^{(i)}) \neq y^{(i)})$$

$$\text{Test error: } \varepsilon_{\mu}(f) := \mathbb{E}_{\mu} [\mathbb{I}(f(X) \neq Y)] = \Pr_{\mu}(f(X) \neq Y)$$

We are interested in finding  $f$  that minimizes the test error but we can only observe the training error

# Bayes Error Rate

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Bayes error rate: the theoretically minimum test error that can be achieved:

$$\text{Bayes error: } \varepsilon_{\mu}^* := \inf_{f: \mathcal{X} \rightarrow \mathcal{Y}} \varepsilon_{\mu}(f)$$

Assuming  $X$  is a continuous RV and let  $p(x)$  be the probability density of  $X$ . Then for any classifier  $f: \mathcal{X} \rightarrow \{0,1\}$ , we have:

$$\begin{aligned} \varepsilon_{\mu}(f) &= \Pr_{\mu}(f(X) \neq Y) \\ &= \int_{\mathcal{X}} \left( \Pr_{\mu}(Y = 1 | X = x) \cdot \mathbb{I}(f(x) = 0) + \Pr_{\mu}(Y = 0 | X = x) \cdot \mathbb{I}(f(x) = 1) \right) p(x) \, dx \\ &\geq \int_{\mathcal{X}} \min \left\{ \Pr_{\mu}(Y = 1 | X = x), \Pr_{\mu}(Y = 0 | X = x) \right\} p(x) \, dx \\ &= \mathbb{E}_{\mu} \left[ \min \left\{ \Pr_{\mu}(Y = 1 | X), \Pr_{\mu}(Y = 0 | X) \right\} \right] \\ &= \frac{1}{2} - \frac{1}{2} \mathbb{E}_{\mu} [|2\eta(X) - 1|] \end{aligned}$$

where  $\eta(X) := \Pr_{\mu}(Y = 1 | X)$  is the conditional probability

# Bayes Error Rate

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Bayes error depends on the distribution  $\mu$ :

$$\begin{aligned}\varepsilon_\mu(f) &= \Pr_\mu(f(X) \neq Y) \\ &= \int_{\mathcal{X}} \left( \Pr_\mu(Y = 1 | X = x) \cdot \mathbb{I}(f(x) = 0) + \Pr_\mu(Y = 0 | X = x) \cdot \mathbb{I}(f(x) = 1) \right) p(x) \, dx \\ &\geq \int_{\mathcal{X}} \min \left\{ \Pr_\mu(Y = 1 | X = x), \Pr_\mu(Y = 0 | X = x) \right\} p(x) \, dx \\ &= \mathbb{E}_\mu \left[ \min \left\{ \Pr_\mu(Y = 1 | X), \Pr_\mu(Y = 0 | X) \right\} \right] \\ &= \boxed{\frac{1}{2} - \frac{1}{2} \mathbb{E}_\mu [|2\eta(X) - 1|]} \quad \text{Bayes error rate: } \varepsilon_\mu^*\end{aligned}$$

- The Bayes error only depends on the distribution  $\mu$
- It's unknown since we don't know  $\mu$  in practice
- It's always  $\leq 0.5$

# Bayes Error Rate

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The classifier that achieves the Bayes error is called the **Bayes classifier**, and it has the following form:

$$\eta(X) := \Pr(Y = 1 \mid X)$$

$$f_{\text{Bayes}}(X) := \begin{cases} 1 & \text{if } \eta(X) \geq \frac{1}{2} \\ 0 & \text{otherwise} \end{cases}$$

- Again, this is unknown since we don't know  $\mu$
- Recall the proof:

$$\begin{aligned} \varepsilon_{\mu}(f) &= \int_{\mathcal{X}} \left( \Pr(Y = 1 \mid X = x) \cdot \mathbb{I}(f(x) = 0) + \Pr(Y = 0 \mid X = x) \cdot \mathbb{I}(f(x) = 1) \right) p(x) \, dx \\ &\geq \int_{\mathcal{X}} \min \left\{ \Pr(Y = 1 \mid X = x), \Pr(Y = 0 \mid X = x) \right\} p(x) \, dx \\ &= \frac{1}{2} - \frac{1}{2} \mathbb{E}_{\mu} [|2\eta(X) - 1|] \end{aligned}$$

Think: when will  $\varepsilon_{\mu}^* = 0$ ? when will  $\varepsilon_{\mu}^* = 0.5$ ?



# Bayes Error Rate

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Intuitively, the Bayes error is a measure of the “noise” in the underlying distribution:

**Bayes error rate:**  $\varepsilon_{\mu}^* = \frac{1}{2} - \frac{1}{2} \mathbb{E} [ |2\eta(X) - 1| ]$

$$\eta(X) := \Pr(Y = 1 \mid X)$$

- If  $\forall x, \eta(x) = 1$ , or  $\eta(x) = 0$ , then  $\varepsilon_{\mu}^* = 0$
- If  $\forall x, \eta(x) = \frac{1}{2}$ , then  $\varepsilon_{\mu}^* = \frac{1}{2}$

# Bayes Error Rate

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Intuitively, the Bayes error is a measure of the “noise” in the underlying distribution:

**Bayes error rate:**  $\epsilon_{\mu}^* = \frac{1}{2} - \frac{1}{2} \mathbb{E} [ |2\eta(X) - 1| ]$

$$\eta(X) := \Pr(Y = 1 \mid X)$$

**Example:** Suppose we have the following data generative process. There exists a vector  $w^*$ , such that for each  $x$ , the labels are generated in the following process:

- First, compute the label  $y = \text{sgn}(w^{*\top} x)$
- Then, with probability  $0 < p < 0.5$ , flip the label  $y$

**Question:** What's the Bayes error rate for this example?

# Bayes Error Rate

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The concept is not unique to classification problems. For regression problems, under the squared loss:

$$\begin{aligned}\forall f, \varepsilon_{\mu}(f) &= \mathbb{E}_{\mu} [(f(X) - Y)^2] \\ &= \mathbb{E}_X \mathbb{E}_Y [(f(X) - Y)^2 | X] \\ &= \mathbb{E}_X \mathbb{E}_Y [(f(X) - \mathbb{E}[Y|X] + \mathbb{E}[Y|X] - Y)^2 | X] \\ &= \mathbb{E}_X \mathbb{E}_Y [(f(X) - \mathbb{E}[Y|X])^2 + (\mathbb{E}[Y|X] - Y)^2 \\ &\quad + \cancel{2(f(X) - \mathbb{E}[Y|X])(\mathbb{E}[Y|X] - Y)} | X] \\ &\geq \mathbb{E}_X \mathbb{E}_Y [(\mathbb{E}[Y|X] - Y)^2 | X]\end{aligned}$$

**Bayes error rate:**  $= \mathbb{E}_X \text{Var}[Y | X]$

**Bayes optimal regressor:**  $f_{\text{Bayes}}(X) = \mathbb{E}[Y | X]$

# Bayes Error Rate

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Again, the Bayes error in regression can also be understood as a measure of the “noise” in the underlying distribution:

**Bayes error rate:**  $\epsilon_{\mu}^* = \mathbb{E} \text{Var}[Y|X]$

**Example:** Suppose we have the following data generative process. There exists a vector  $w^*$ , such that for each  $x$ , the labels are generated in the following process:

- First, compute the label  $y = w^{*\top} x$
- Then, inject a white noise  $\epsilon \sim \mathcal{N}(0, \delta^2)$  into the label so that  $y \leftarrow y + \epsilon$

**Question:** What's the Bayes error under the squared loss for this example?

# Bayes Error Rate

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The optimal error a learner can hope to achieve also depends on the class of functions  $\mathcal{F}$  it can choose from, called **hypothesis class**

For binary classification problems:

- If  $\mathcal{F}$  contains all the binary functions, then  $\inf_{f \in \mathcal{F}} \varepsilon_{\mu}(f) = \varepsilon_{\mu}^*$
- If  $\mathcal{F}$  is very restricted, e.g., only contains constant functions, then  $\inf_{f \in \mathcal{F}} \varepsilon_{\mu}(f) = \min\{\Pr(Y = 0), \Pr(Y = 1)\}$

Clearly, in the second case, the error is larger than the Bayes error.

# Bayes Error Rate

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The optimal error a learner can hope to achieve also depends on the class of functions  $\mathcal{F}$  it can choose from, called **hypothesis class**

For regression problems under mean-squared error:

- If  $\mathcal{F}$  contains all the real-valued functions, then  $\inf_{f \in \mathcal{F}} \varepsilon_{\mu}(f) = \varepsilon_{\mu}^*$
- If  $\mathcal{F}$  is very restricted, e.g., only contains constant functions, then  $\inf_{f \in \mathcal{F}} \varepsilon_{\mu}(f) = \text{Var}[Y]$

In the second case, the error is larger than the Bayes error by the law of total variance:  $\text{Var}[Y] = \mathbb{E}\text{Var}[Y|X] + \text{Var}\mathbb{E}[Y|X] \geq \mathbb{E}\text{Var}[Y|X]$

# Bayes Error Rate

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Summary:

Binary classification:

**Bayes error rate:**  $\varepsilon_{\mu}^* = \mathbb{E} \min \{ \Pr(Y = 1 | X), \Pr(Y = 0 | X) \}$

**Bayes optimal classifier:**  $f_{\text{Bayes}}(X) := \begin{cases} 1 & \text{if } \Pr(Y = 1 | X) \geq \frac{1}{2} \\ 0 & \text{otherwise} \end{cases}$

Regression with squared loss:

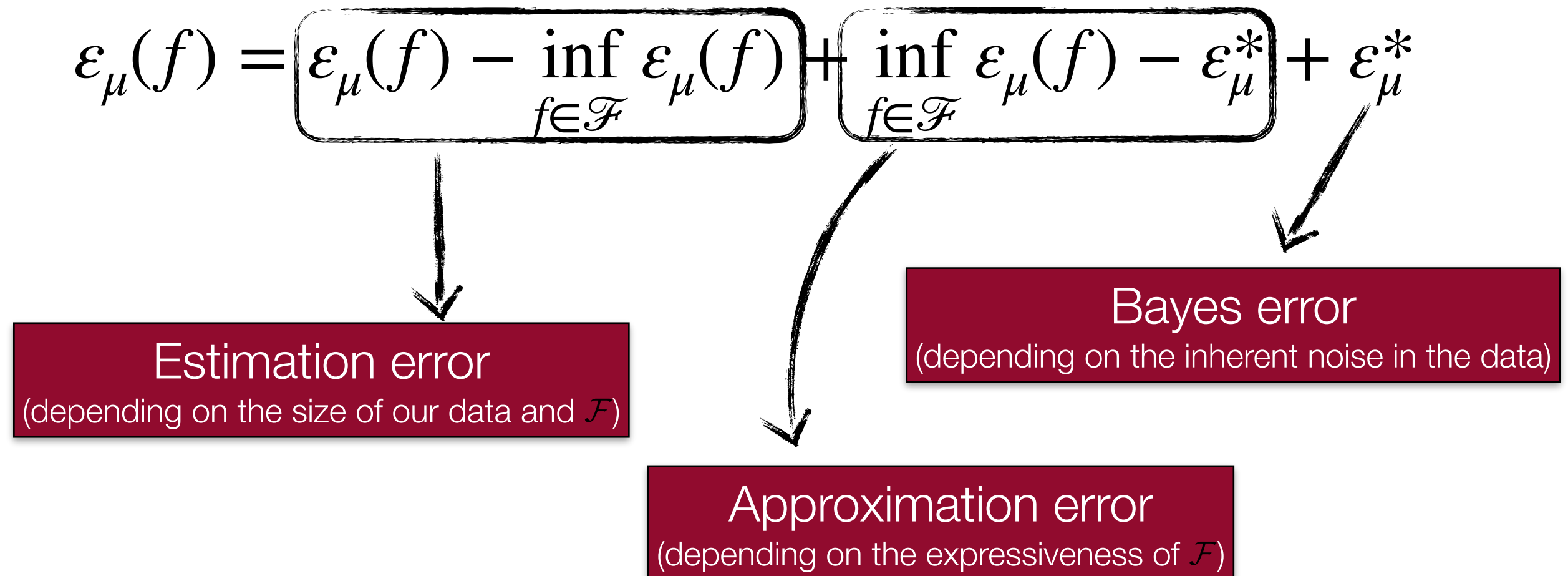
**Bayes error rate:**  $\varepsilon_{\mu}^* = \mathbb{E} \text{Var}[Y | X]$

**Bayes optimal regressor:**  $f_{\text{Bayes}}(X) = \mathbb{E}[Y | X]$

# Error Decomposition

For a given hypothesis class  $\mathcal{F}$ , we may have  $f_{\text{Bayes}} \notin \mathcal{F}$ . In this case we cannot hope to achieve  $\varepsilon_{\mu}^*$ , but instead  $\inf_{f \in \mathcal{F}} \varepsilon_{\mu}(f)$ .

Error decomposition:  $\forall f \in \mathcal{F}$ :





# Error Decomposition

Error decomposition:  $\forall f \in \mathcal{F}$ :

$$\varepsilon_\mu(f) = \underbrace{\varepsilon_\mu(f) - \inf_{f \in \mathcal{F}} \varepsilon_\mu(f)}_{\text{Estimation error}} + \underbrace{\inf_{f \in \mathcal{F}} \varepsilon_\mu(f) - \varepsilon_\mu^*}_{\text{Approximation error}} + \underbrace{\varepsilon_\mu^*}_{\text{Bayes error}}$$

**Estimation error**  
(depending on the size of our data and  $\mathcal{F}$ )

**Bayes error**  
(depending on the inherent noise in the data)

**Approximation error**  
(depending on the expressiveness of  $\mathcal{F}$ )

- Often the case, there is a trade-off between the estimation error and the approximation error
- If  $\mathcal{F}$  is more expressive, then the approximation error gets smaller but the estimation error gets larger
- If  $\mathcal{F}$  is more restricted, then the approximation error gets larger but the estimation error gets smaller (assume the size of training data is fixed)

# Error Decomposition

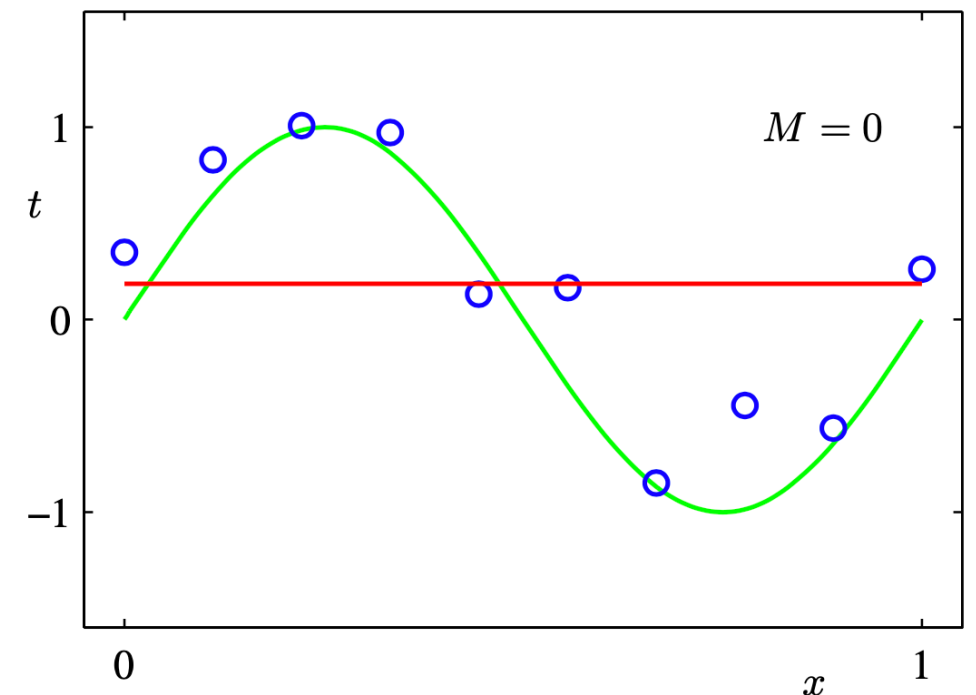
Example: fitting a trigonometric function with polynomials  
(degree =  $M$ )

Degree 0

Bayes classifier



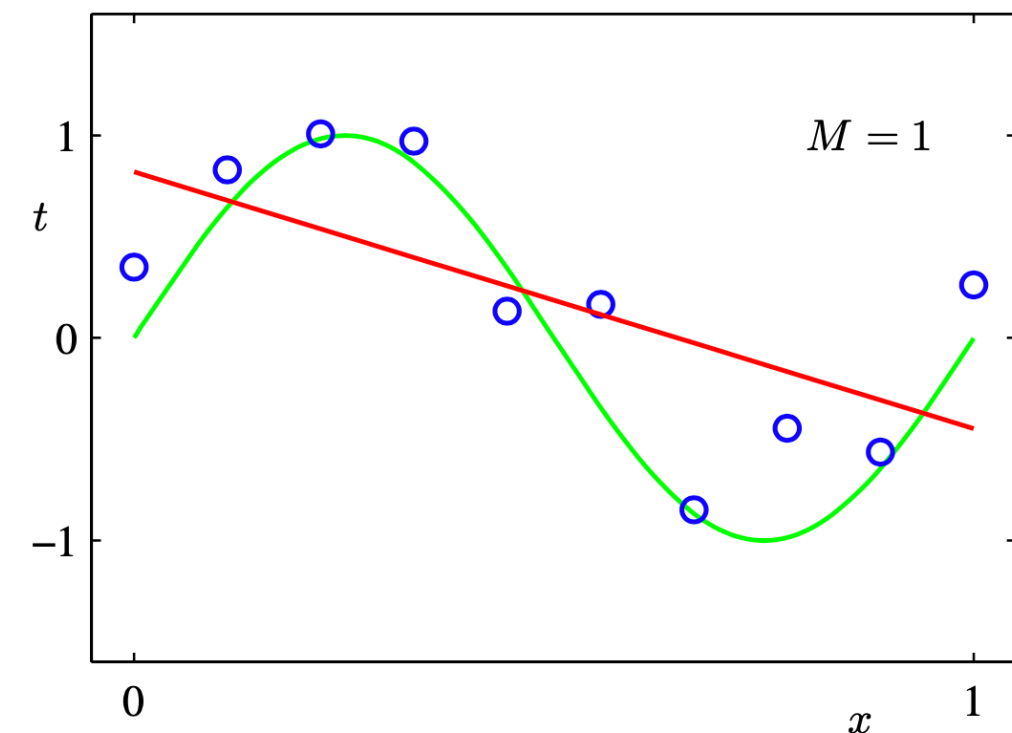
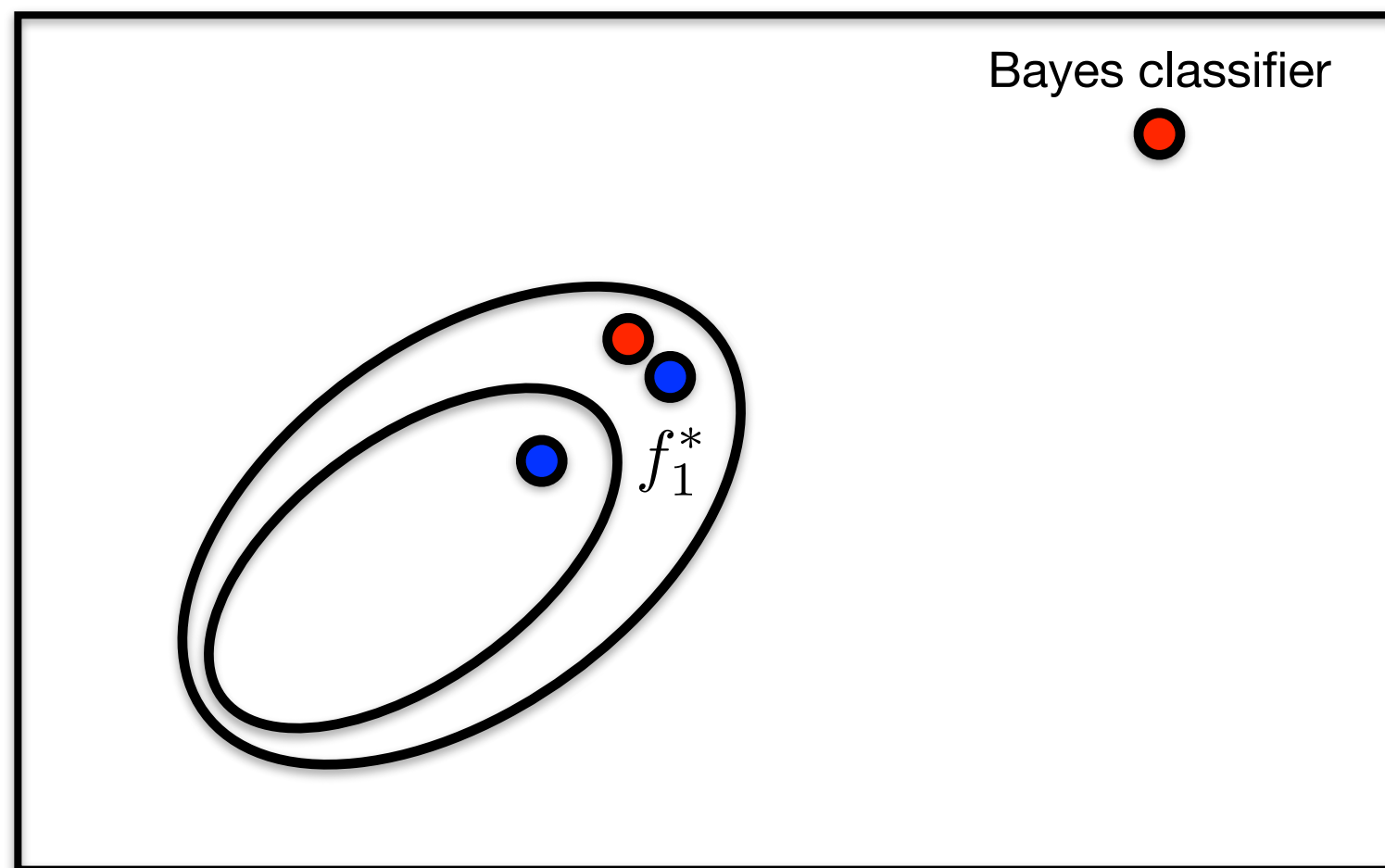
$f_0^*$



# Error Decomposition

Example: fitting a trigonometric function with polynomials  
(degree =  $M$ )

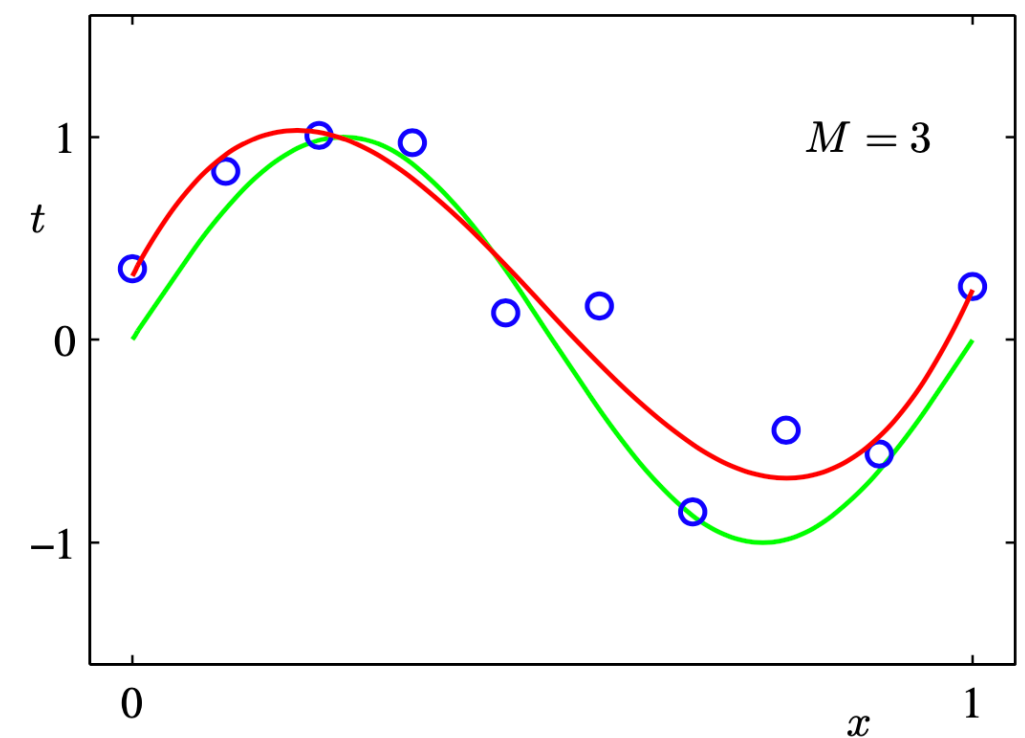
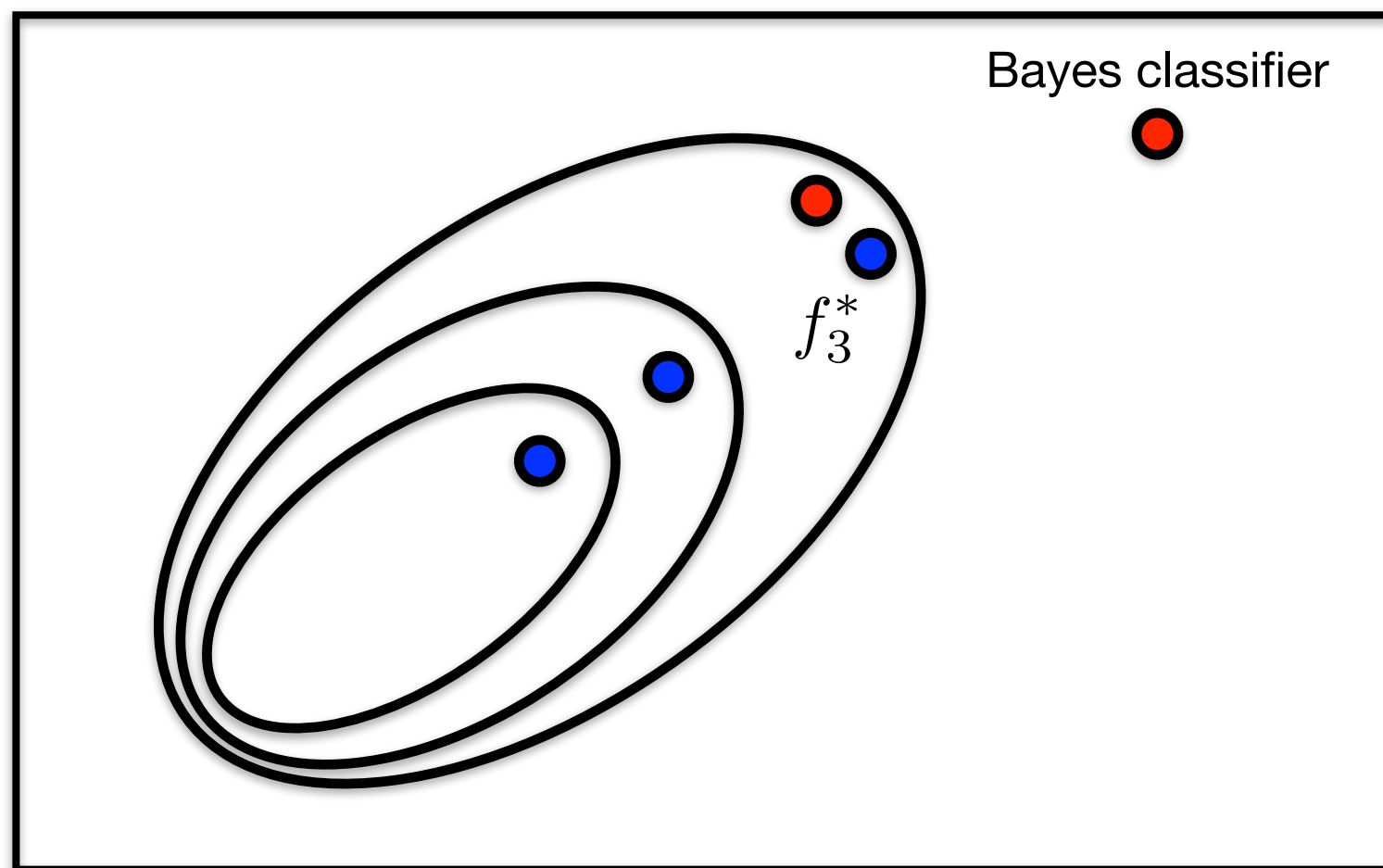
Degree 1



# Error Decomposition

Example: fitting a trigonometric function with polynomials  
(degree =  $M$ )

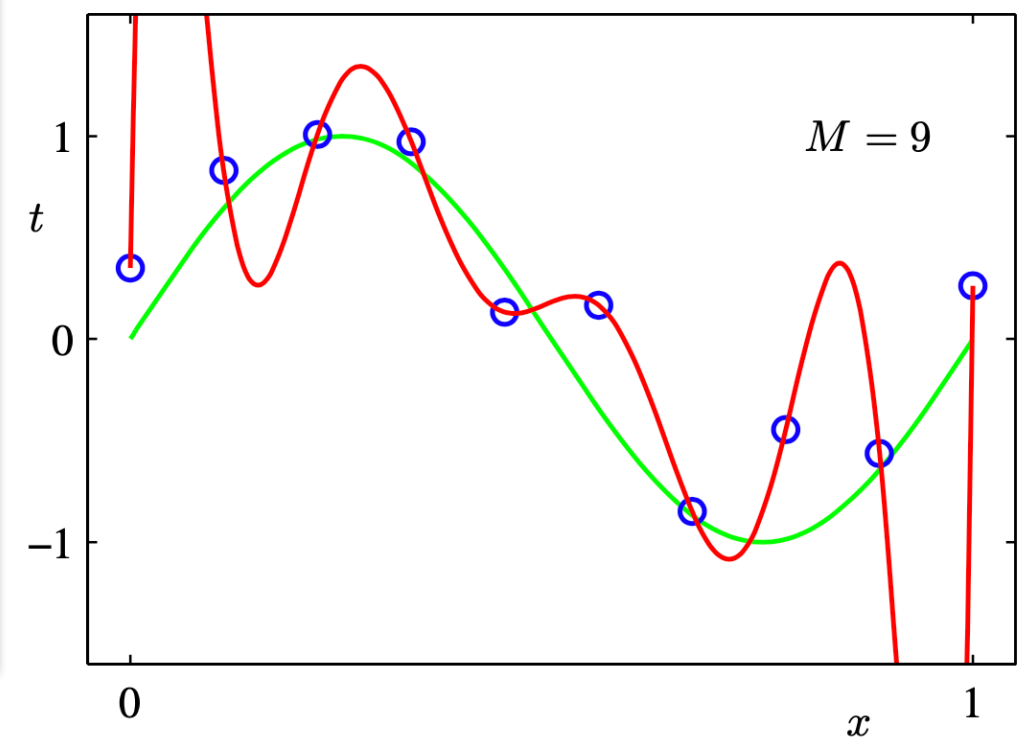
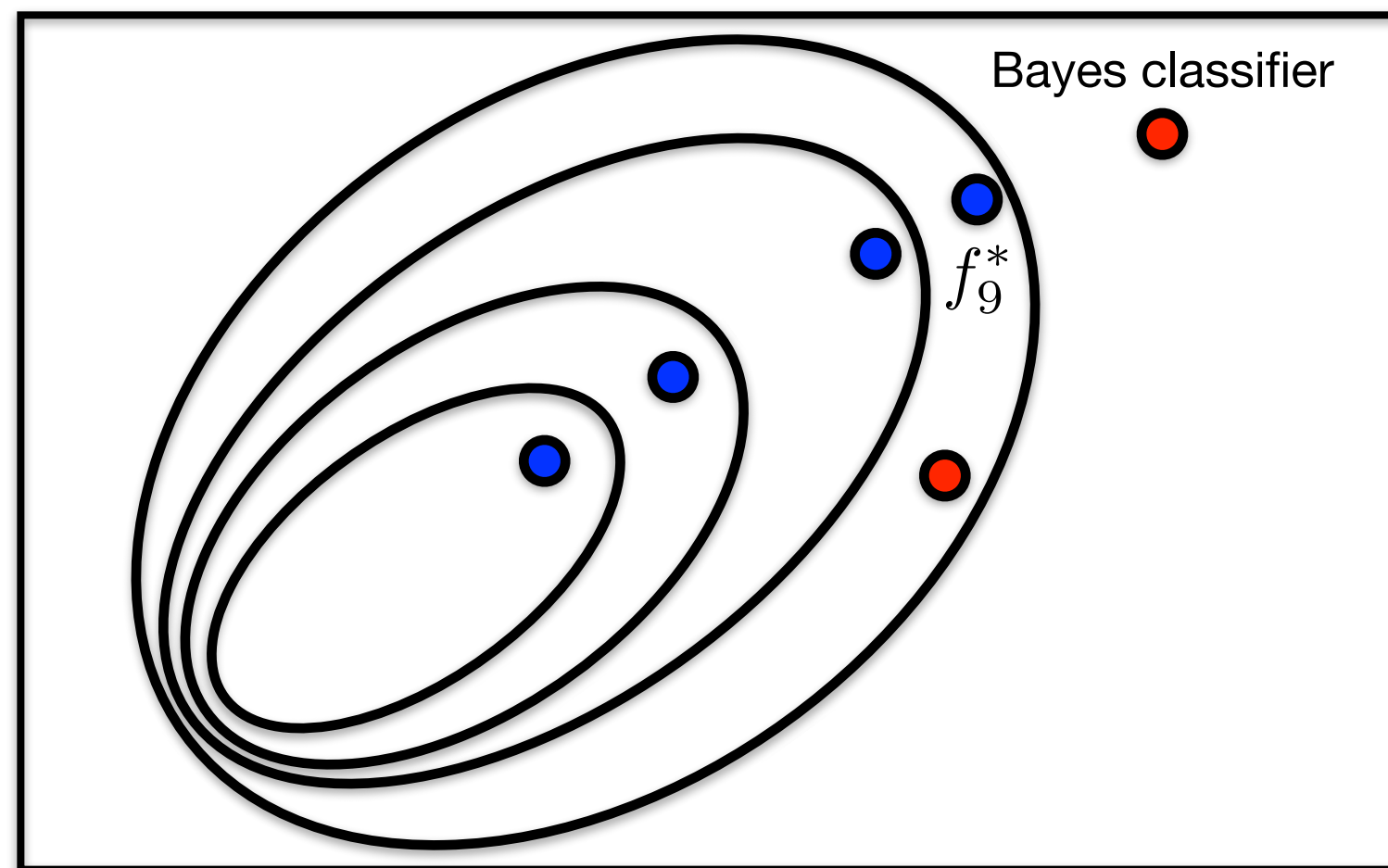
Degree 3



# Error Decomposition

Example: fitting a trigonometric function with polynomials  
(degree =  $M$ )

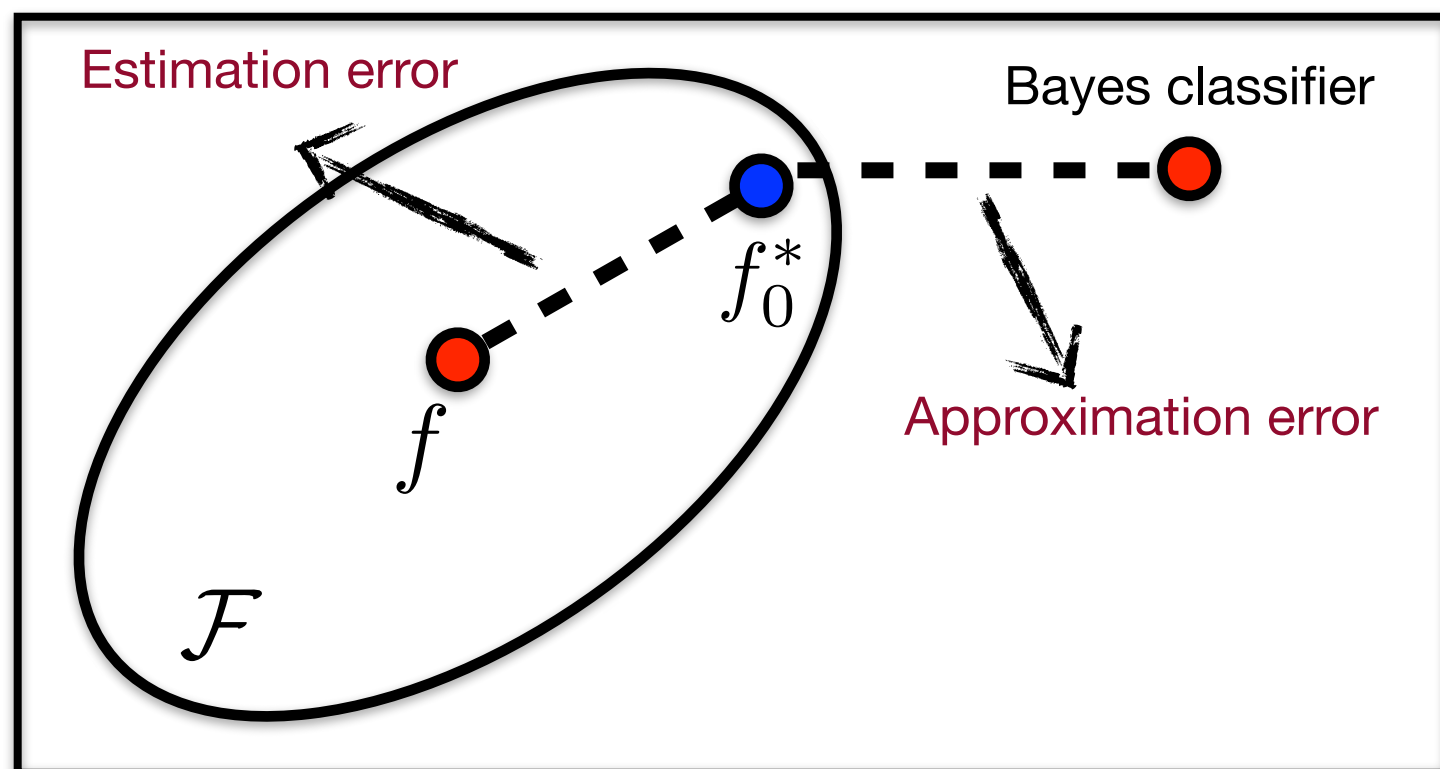
Degree 9



# Error Decomposition

Reminder: the approximation error only depends on  $\mathcal{F}$  while the estimation error depends on both  $\mathcal{F}$  and data

- We should aim to minimize the estimation error
- How does the estimation error depend on the sample size, the expressiveness/richness of  $\mathcal{F}$ , or the distribution  $\mu$ ?
- Ideally, for a fixed hypothesis class  $\mathcal{F}$ , could we ensure that the estimation error goes to 0 as the sample size  $n$  increases?



# Next Time

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- Probably Approximately Correct (PAC) framework
- High-probability generalization bound
- Vapnik–Chervonenkis dimension (VC dim)